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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/749,550	ZHANG, XIN	
Examiner	Art Unit	_
Cindy D. Khuu	2863	

SEARCHED			
Class	Subclass	Date	Examiner
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INTERFERENCE SEARCHED			
Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
IEEE Xplore Release 2.1 Google Search	10/27/2005	СНК
USPTO East Databases: US-PGPUB, USPAT, EPO, JPO, DERWENT, IBM_TDB. 705/\$, 702/\$ (Text Only)	10/28/2005	снк
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